

PATENT

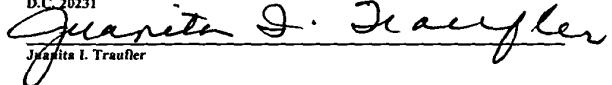
IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Peter Paul Zilla et al Serial No.:09/434,069

Filed: Herewith Docket: P-8794.05 C2

Title: Transmural Concentric Multilayer IngrowthMatrix within Well-Defined Porosity
CERTIFICATE OF MAILING DATE OF DEPOSIT 7-25-03

I hereby certify that this paper is being deposited with the U.S. Postal Service, as
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Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Dear Sir:

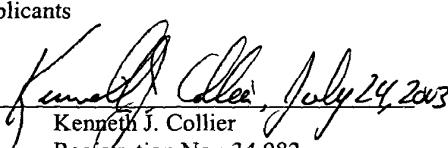
In compliance with the duty imposed by 37 C.F.R. § 1.56, and in accordance with C.F.R. §§ 1.97 *et. seq.*, the materials enclosed herewith are brought to the attention of the Examiner as possibly being of interest in connection with the above-identified patent application. Consideration of each of the documents listed on the attached Form 1449 is respectfully requested. Pursuant to the provisions of M.P.E.P. § 609, Applicant further requests that a copy of the Form 1449, marked as being considered and initialed by the Examiner, be returned with the next Official Communication.

The Examiner's attention is brought to Applicants' filed U.S. Patent Application USSN 09/434,069 filed November 5, 1999 and USSN 10/142,957 filed May 10,2002, and the art cited therein.

Respectfully submitted,

Applicants

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PATENT TRADEMARK OFFICE

INFORMATION DISCLOSURE STATEMENT	Atty Docket No: P8794.00		Serial No.: 09/434.069
	Applicant(s): Zilla, Peter et al.		
	Filing Date: 05-Nov-99	Group: 3738	

US PATENT DOCUMENTS

Examiner Initial	+/*	Document Number	Date	Name	Class	SubClass	Filing Date If Appropriate
		US 4,286,341	01-Sep-81	Greer, Raymont T. et al.	3	1.4	23-May-79
		US 4,441,215	10-Apr-84	Kaster, Robert	3	1.4	23-Feb-83
		US 4,552,707	12-Nov-85	How, Thien V.	264	24	09-May-83
		US 4,605,406	12-Aug-86	Cahalan, Patrick	623	1	03-Aug-84
		US 4,657,544	14-Apr-87	Pinchuk, Leonard	623/1	623/12	18-Apr-84
		US 4,725,273	16-Feb-88	Kira	623/1	623/12	20-Aug-86
		US 4,743,252	10-May-88	Martin, John, Jr., et al.	623	1	13-Jan-86
		US 4,784,659	15-Nov-88	Fleckenstein, Peter et al.	623	1	03-Mar-87
		US 4,842,575	27-Jun-89	Hoffman, Harmon, Jr., et al.	600	36	05-Aug-88
		US 4,873,308	10-Oct-89	Coury, Arthur J., et al.	528	75	30-Sep-88
		US 4,921,495	01-May-90	Kira, Kazuaki	623	1	24-Mar-86
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		US 5,037,377	06-Aug-91	Alonso, Manuel T., et al.	600	36	21-Aug-86
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		US 5,415,619	16-May-95	Lee, Hai B., et al.	600	36	05-Nov-93
		US 5,549,664	27-Aug-96	Hirata et al.	623/1	600/36	02-May-94
		US 5,584,875	17-Dec-96	Duhamel, Raymond C., et al.	623	1	13-Apr-94
		US 5,628,781	13-May-97	Williams, Stuart et al.	623	1	29-Sep-92
		US 5,709,934	20-Jan-98	Bell, Eugene	428	305.5	22-Nov-94
		US 5,770,417	23-Jun-98	Vacanti, Joseph P., et al.	435	180	28-Feb-94
		US 5,807,406	15-Sep-98	Brauker, James H.	623	11	07-Oct-94

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		EP 0815806 A2	07-Jan-98	Solovay, Kenneth S.	A61F 2/06		26-Jun-97
		EP 560279A1	15-Sep-93	Kaplan, Richard B.	A61L	27/00	09-Mar-93

EXAMINER	Date Considered
Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP609: Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. * - Reference Previously cited + - New Reference not previously cited (available copies included).	

		WO 90/06094	14-Jun-90	Trudell, Leonard et al.	A61F 2/06		08-Dec-88
		WO 9715242	01-May-97	Seeley, David	A61F	2/02	25-Oct-95
		WO 9747254	18-Dec-97	Glodstein, Steven	A61B	19/00	11-Jun-97

OTHER DOCUMENTS (Including Authors, title, Date, Pertinent Papers, etc.)

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		Annis et al., Trans. Am. Soc. Artif. Intern Organs, Vol. XXIV, 1978, pp 209-214
		Berkowitz, Henry D., et al., Amer Soc Artif Int Organs, Vol XVIII, 1972, pp 25-29
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		Edwards, Alan et al., Jrnal of Biomaterials Applications, Vol 10, Oct 1995, pp 171-187
		Hess, F., J. Cardiovascular Surgery, 24, 1983
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		Hess, F., M.D. et al., Jrnal of Cardio Surg, Vol 22, 1992, pp 358-365
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		White, Rodney, A., et al., Surgery, Vol 79, No. 2, Feb 1976, pp 229-232
		Williams, Stuart K., et al., Jrnal of Biomedical Materials Research, Vol 26, pp 103-117
		Wilson, G.J., Trans Am Soc Artif Intern Organs, Vol XXIX, 1983, pp 260-268

EXAMINER	Date Considered
Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP609: Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

* - Reference Previously cited

+ - New Reference not previously cited (available copies included).

Based on Form PTO-FB-A820
(Also form PTO-1449)

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